EP2645TTS-40.5504M

RoHS Compliant (Pb-free) 3.3V 4 Pad 5mm x 7mm

Ceramic SMD LVCMOS Programmable Oscillator

Series



-40.5504M EP26 45 т TS

Nominal Frequency

40.5504MHz

Pin 1 Connection

Tri-State (Disabled Output: High Impedance)

±50ppm Maximum Operating Temperature Range -20°C to +70°C

Frequency Tolerance/Stability

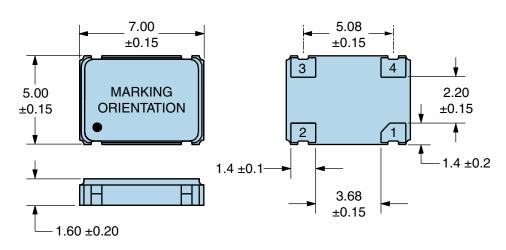
Duty Cycle 50 ±5(%)

ELECTRICAL SPECIFICATIONS Nominal Frequency 40.5504MHz ±50ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the **Frequency Tolerance/Stability** Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration) Aging at 25°C ±5ppm/year Maximum **Operating Temperature Range** -20°C to +70°C Supply Voltage 3.3Vdc ±0.3Vdc Input Current 28mA Maximum (Unloaded) Output Voltage Logic High (Voh) Vdd-0.4Vdc Minimum (IOH= -8mA) **Output Voltage Logic Low (Vol)** 0.4Vdc Maximum (IOL= +8mA) **Rise/Fall Time** 4nSec Maximum (Measured at 20% to 80% of waveform) **Duty Cycle** 50 ±5(%) (Measured at 50% of waveform) Load Drive Capability 30pF Maximum **Output Logic Type** CMOS **Pin 1 Connection** Tri-State (Disabled Output: High Impedance) Tri-State Input Voltage (Vih and Vil) 70% of Vdd Minimum to enable output, 20% of Vdd Maximum to disable output, No Connect to enable output. Standby Current $20\mu A$ Maximum (Pin 1 = Ground) **Disable Current** 16mA Maximum (Pin 1 = Ground) Absolute Clock Jitter ±125pSec Maximum, ±75pSec Typical **One Sigma Clock Period Jitter** ±40pSec Maximum Start Up Time 10mSec Maximum Storage Temperature Range -55°C to +125°C **ENVIRONMENTAL & MECHANICAL SPECIFICATIONS** ESD Susceptibility MIL-STD-883, Method 3015, Class 1, HBM: 1500V

MIL-STD-883, Method 1014, Condition A
UL94-V0
MIL-STD-883, Method 1014, Condition C
MIL-STD-883, Method 2002, Condition B
MIL-STD-883, Method 1004
J-STD-020, MSL 1
MIL-STD-202, Method 210, Condition K
MIL-STD-202, Method 215
MIL-STD-883, Method 2003
MIL-STD-883, Method 1010, Condition B
MIL-STD-883, Method 2007, Condition A

EP2645TTS-40.5504M

MECHANICAL DIMENSIONS (all dimensions in millimeters)



PIN	CONNECTION		
1	Tri-State (High Impedance)		
2	Ground/Case Ground		
3	Output		
4	Supply Voltage		
LINE	MARKING		
1	ECLIPTEK		
2	40.550M		
3	PXXYZZ P=Configuration Designator XX=Ecliptek Manufacturing Code		

Y=Last Digit of the Year ZZ=Week of the Year

ECL

ORPORATION

K

Suggested Solder Pad Layout

All Dimensions in Millimeters

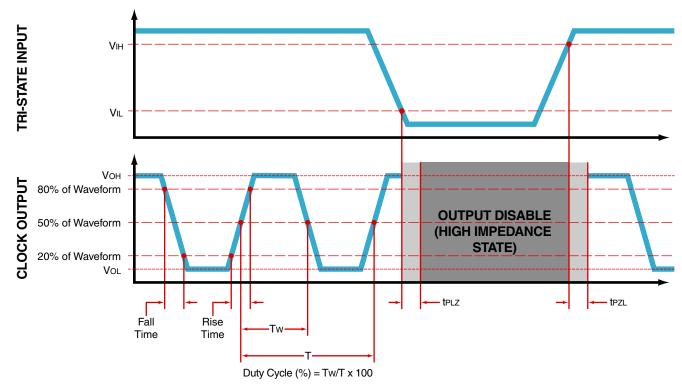


All Tolerances are ±0.1

EP2645TTS-40.5504M



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output



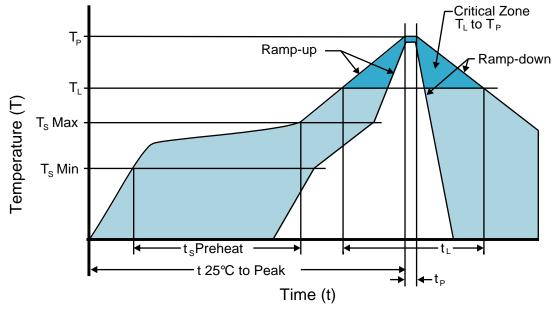
Note 1: An external 0.1μ F low frequency tantalum bypass capacitor in parallel with a 0.01μ F high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value C_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



High Temperature Infrared/Convection

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<u> </u>	
T _s MAX to T _L (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	150°C
- Temperature Typical (T _s TYP)	175°C
 Temperature Maximum (T_s MAX) 	200°C
- Time (t _s MIN)	60 - 180 Seconds
Ramp-up Rate (T⊾ to T _P)	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T _P Target)	250°C +0/-5°C
Time within 5°C of actual peak (t _p)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.



Recommended Solder Reflow Methods

EP2645TTS-40.5504M



Low Temperature Infrared/Convection 240°C

T_s MAX to T_L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _s TYP)	150°C
 Temperature Maximum (T_s MAX) 	N/A
- Time (t _s MIN)	60 - 120 Seconds
Ramp-up Rate (T _L to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	240°C Maximum
Target Peak Temperature (T _P Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (t _p)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)